

DG408, DG409

Single 8-Channel/Differential 4-Channel, CMOS Analog Multiplexers

FN3283 Rev 8.00 Jun 13, 2006

The DG408 Single 8-Channel, and DG409 Differential 4-Channel monolithic CMOS analog multiplexers are drop-in replacements for the popular DG508A and DG509A series devices. They each include an array of eight analog switches, a TTL/CMOS compatible digital decode circuit for channel selection, a voltage reference for logic thresholds and an ENABLE input for device selection when several multiplexers are present.

The DG408 and DG409 feature lower signal ON resistance (<100 Ω) and faster switch transition time (t_{TRANS} < 250ns) compared to the DG508A or DG509A. Charge injection has been reduced, simplifying sample and hold applications. The improvements in the DG408 series are made possible by using a high-voltage silicon-gate process. An epitaxial layer prevents the latch-up associated with older CMOS technologies. Power supplies may be single-ended from +5V to +34V, or split from \pm 5V to \pm 20V.

The analog switches are bilateral, equally matched for AC or bidirectional signals. The ON resistance variation with analog signals is quite low over a ± 5 V analog input range.

Features

•	ON Resistance (Max, 25°C) 100 Ω
•	Low Power Consumption (PD) $\dots <11$ mW
•	Fast Switching Action
	- t _{TRANS}
	- t _{ON/OFF(EN)}

- · Low Charge Injection
- · Upgrade from DG508A/DG509A
- · TTL, CMOS Compatible
- · Single or Split Supply Operation
- Pb-Free Plus Anneal Available (RoHS Compliant)

Applications

- · Data Acquisition Systems
- · Audio Switching Systems
- · Automatic Testers
- · Hi-Rel Systems
- Sample and Hold Circuits
- · Communication Systems
- · Analog Selector Switch

Ordering Information

PART NUMBER	PART MARKING	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
DG408DJ	DG408DJ	-40 to 85	16 Ld PDIP	E16.3
DG408DJZ (Note)	DG408DJZ	-40 to 85	16 Ld PDIP** (Pb-free)	E16.3
DG408DY*	DG408DY	-40 to 85	16 Ld SOIC	M16.15
DG408DYZ* (Note)	DG408DYZ	-40 to 85	16 Ld SOIC (Pb-free)	M16.15
DG408DVZ* (Note)	DG408DVZ	-40 to 85	16 Ld TSSOP (Pb-free)	M16.173
DG409DJ	DG409DJ	-40 to 85	16 Ld PDIP	E16.3
DG409DJZ (Note)	DG409DJZ	-40 to 85	16 Ld PDIP** (Pb-free)	E16.3
DG409DY*	DG409DY	-40 to 85	16 Ld SOIC	M16.15
DG409DYZ* (Note)	DG409DYZ	-40 to 85	16 Ld SOIC (Pb-free)	M16.15
DG409DVZ* (Note)	DG409DVZ	-40 to 85	16 Ld TSSOP (Pb-free)	M16.173

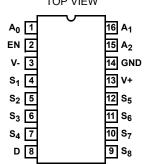
^{*}Add "-T" suffix for tape and reel.

^{**}Pb-free PDIPs can be used for through hole wave solder processing only. They are not intended for use in Reflow solder processing applications.

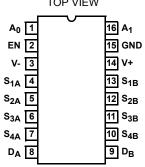
NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

Pinouts

DG408 (PDIP, SOIC, TSSOP) TOP VIEW

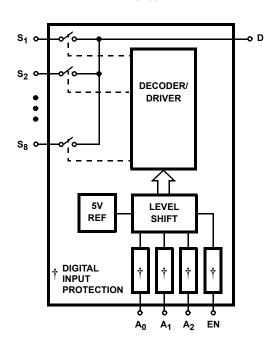


DG409 (PDIP, SOIC, TSSOP) TOP VIEW

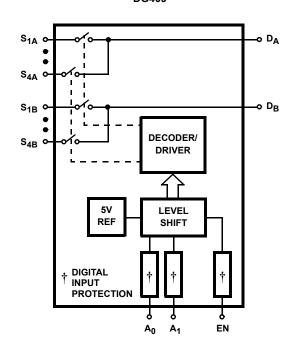


Functional Block Diagrams

DG408



DG409



TRUTH TABLE DG408

A ₂	A ₁	A ₀	EN	ON SWITCH
Х	Х	Х	0	NONE
0	0	0	1	1
0	0	1	1	2
0	1	0	1	3
0	1	1	1	4
1	0	0	1	5
1	0	1	1	6
1	1	0	1	7
1	1	1	1	8

TRUTH TABLE DG409

A ₁	Α ₀	EN	ON SWITCH
Х	Х	0	NONE
0	0	1	1
0	1	1	2
1	0	1	3
1	1	1	4

NOTES:

- 1. V_{AH} Logic "1" ≥2.4V.
- 2. V_{AL} Logic "0" \leq 0.8V.



Pin Descriptions - (DG408)

PIN	SYMBOL	DESCRIPTION
1	A ₀	Logic Decode Input (Bit 0, LSB)
2	EN	Enable Input
3	V-	Negative Power Supply Terminal
4	S ₁	Source (Input) for Channel 1
5	S ₂	Source (Input) for Channel 2
6	S ₃	Source (Input) for Channel 3
7	S ₄	Source (Input) for Channel 4
8	D	Drain (Output)
9	S ₈	Source (Input) for Channel 8
10	S ₇	Source (Input) for Channel 7
11	S ₆	Source (Input) for Channel 6
12	S ₅	Source (Input) for Channel 5
13	V+	Positive Power Supply Terminal (Substrate)
14	GND	Ground Terminal (Logic Common)
15	A ₂	Logic Decode Input (Bit 2, MSB)
16	A ₁	Logic Decode Input (Bit 1)

Pin Descriptions - (DG409)

PIN	SYMBOL	DESCRIPTION
1	A ₀	Logic Decode Input (Bit 0, LSB)
2	EN	Enable Input
3	V-	Negative Power Supply Terminal
4	S _{1A}	Source (Input) for Channel 1a
5	S _{2A}	Source (Input) for Channel 2a
6	S _{3A}	Source (Input) for Channel 3a
7	S _{4A}	Source (Input) for Channel 4a
8	D _A	Drain a (Output a)
9	D _B	Drain b (Output b)
10	S _{4B}	Source (Input) for Channel 4b
11	S _{3B}	Source (Input) for Channel 3b
12	S _{2B}	Source (Input) for Channel 2b
13	S _{1B}	Source (Input) for Channel 1b
14	V+	Positive Power Supply Terminal
15	GND	Ground Terminal (Logic Common)
16	A ₁	Logic Decode Input (Bit 1, MSB)



Absolute Maximum Ratings Thermal Information Thermal Resistance (Typical, Note 4) θ_{JA} (°C/W) GND to V-......25V Digital Inputs, V_S , V_D (Note 3). (V-) -2V to (V+) + 2V or 20mA, 110 Whichever Occurs First Peak Current, S or D (Pulsed 1ms, 10% Duty Cycle Max) . . 100mA Maximum Storage Temperature Range -65°C to 125°C Maximum Lead Temperature (Soldering 10s) 300°C **Operating Conditions** (SOIC and TSSOP - Lead Tips Only) Temperature Range -40°C to 85°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTES:

- 3. Signals on S_X, D_X, EN or A_X exceeding V+ or V- are clamped by internal diodes. Limit diode current to maximum current ratings.
- 4. $\theta_{\mbox{\scriptsize JA}}$ is measured with the component mounted on an evaluation PC board in free air.

Electrical Specifications Test Conditions: V+ = +15V, V- = -15V, V_{AL} = 0.8V, V_{AH} = 2.4V, Unless Otherwise Specified

			(NOTE E)	(NIOTE O)	(NIOTE E)	
PARAMETER	TEST CONDITIONS	TEMP (°C)	(NOTE 5) MIN	(NOTE 6) TYP	(NOTE 5) MAX	UNITS
DYNAMIC CHARACTERISTICS						
Transition Time, t _{TRANS}	(See Figure 1)	Full	-	160	250	ns
Break-Before-Make Interval, t _{OPEN}	(See Figure 3)	25	10	-	-	ns
Enable Turn-ON Time, t _{ON(EN)}	(See Figure 2)	25	-	115	150	ns
		Full	-	-	225	ns
Enable Turn-OFF Time, t _{OFF(EN)}	(See Figure 2)	Full	-	105	150	ns
Charge Injection, Q	C _L = 10nF, V _S = 0V	25	-	20	-	pC
OFF Isolation	V_{EN} = 0V, R_L = 1k Ω , f = 100kHz (Note 9)	25	-	-75	-	dB
Logic Input Capacitance, C _{IN}	f = 1MHz	25	-	8	-	pF
Source OFF Capacitance, C _{S(OFF)}	V _{EN} = 0V, V _S = 0V, f = 1MHz	25	-	3	-	pF
Drain OFF Capacitance, C _{D(OFF)} DG408	$V_{EN} = 0V, V_D = 0V,$ f = 1MHz	25	-	26	-	pF
DG409		25	-	14	-	pF
Drain ON Capacitance, C _{D(ON)} DG408	V _{EN} = 3V, V _D = 0V, f = 1MHz, V _A = 0V or 3V	25	-	37	-	pF
DG409		25	-	25	-	pF
DIGITAL INPUT CHARACTERISTICS						
Logic Input Current, Input Voltage High, I _{AH}	V _A = 2.4V, 15V	Full	-10	-	10	μА
Logic Input Current, Input Voltage Low, I _{AL}	V _{EN} = 0V, 2.4V, V _A = 0V	Full	-10	-	10	μА
ANALOG SWITCH CHARACTERISTIC	S	-	1	II.	1	1
Analog Signal Range, V _{ANALOG}		Full	-15	-	15	V
Drain-Source ON Resistance,	$V_D = \pm 10V$, $I_S = -10mA$	25	-	40	100	Ω
DS(ON)	(Note 7)	Full	-	-	125	Ω
T _{DS(ON)} Matching Between Channels, ArDS(ON)	V _D = 10V, -10V (Note 8)	25	-	-	15	Ω
Source OFF Leakage Current, I _{S(OFF)}	$V_{EN} = 0V, V_S = \pm 10V,$	25	-0.5	-	0.5	nA
,	$V_D = +10V$	Full	-5	-	5	nA



$\textbf{Electrical Specifications} \quad \text{Test Conditions: } V+ = +15 \text{V}, \ V- = -15 \text{V}, \ V_{AL} = 0.8 \text{V}, \ V_{AH} = 2.4 \text{V}, \ Unless Otherwise Specified} \quad \textbf{(Continued)}$

PARAMETER	TEST CONDITIONS	TEMP (°C)	(NOTE 5) MIN	(NOTE 6) TYP	(NOTE 5) MAX	UNITS
Drain OFF Leakage Current, I _{D(OFF)}	$V_{EN} = 0V, V_D = \pm 10V,$					
DG408	V _S = +10V	25	-1	-	1	nA
		Full	-20	-	20	nA
DG409		25	-1	-	1	nA
		Full	-10	-	10	nA
Drain ON Leakage Current, I _{D(ON)}	$V_S = V_D = \pm 10V \text{ (Note 7)}$					
DG408		25	-1	-	1	nA
		Full	-20	-	20	nA
DG409		25	-1	-	1	nA
		Full	-10	-	10	nA
POWER SUPPLY CHARACTERISTICS				<u> </u>	<u> </u>	
Positive Supply Current, I+	V _{EN} = 0V, V _A = 0V (Standby)	Full	-	10	75	μΑ
Negative Supply Current, I-		Full	-75	1	-	μΑ
Positive Supply Current, I+	V _{EN} = 2.4V, V _A = 0V	25	-	0.2	0.5	mA
	(Enabled)	Full	-	-	2	mA
Negative Supply Current, I-		Full	-500	-	-	μΑ

Electrical Specifications Single Supply Test Conditions: V+ = 12V, V- = 0V, $V_{AL} = 0.8V$, $V_{AH} = 2.4V$, Unless Otherwise Specified

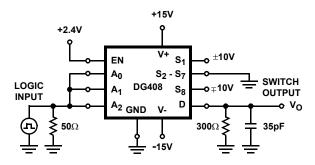
PARAMETER	TEST CONDITION	TEMP (°C)	(NOTE 5) MIN	(NOTE 6) TYP	(NOTE 5) MAX	UNITS
DYNAMIC CHARACTERISTICS	<u>. </u>					
Switching Time of Multiplexer, t _{TRANS}	V _{S1} = 8V, V _{S8} = 0V, V _{IN} = 2.4V	25	-	180	-	ns
Enable Turn-ON Time, t _{ON(EN)}	V _{INH} = 2.4V, V _{INL} = 0V,	25	-	180	-	ns
Enable Turn-OFF Time, t _{OFF(EN)}	V _{S1} = 5V	25	-	120	-	ns
Charge Injection, Q	C_L = 10nF, V_{GEN} = 0V, R_{GEN} = 0Ω	25	-	5	-	рС
ANALOG SWITCH CHARACTERISTIC	S	1	1	1	1	
Analog Signal Range, V _{ANALOG}		Full	0	-	12	V
Drain-Source ON-Resistance, 「DS(ON)	V _D = 3V, 10V, I _S = -1mA (Note 7)	25	-	90	-	Ω

NOTES:

- 5. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- 6. Typical values are for DESIGN AID ONLY, not guaranteed nor production tested.
- 7. Sequence each switch ON.
- 8. $\Delta r_{DS(ON)} = r_{DS(ON)} (Max) r_{DS(ON)} (Min)$.
- 9. Worst case isolation occurs on channel 4 due to proximity to the drain pin.



Test Circuits and Waveforms



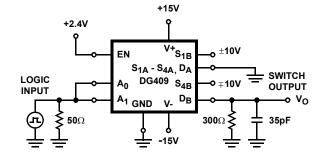


FIGURE 1A. DG408 TEST CIRCUIT

FIGURE 1B. DG409 TEST CIRCUIT

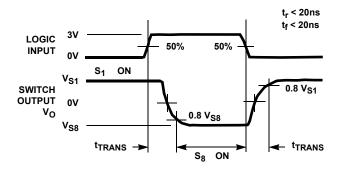


FIGURE 1C. MEASUREMENT POINTS FIGURE 1. TRANSITION TIME

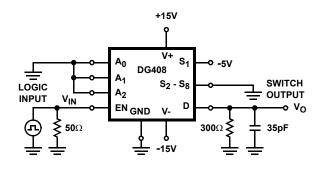


FIGURE 2A. DG408 TEST CIRCUIT

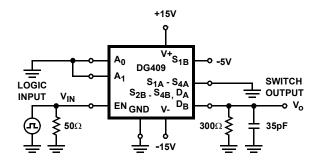


FIGURE 2B. DG409 TEST CIRCUIT

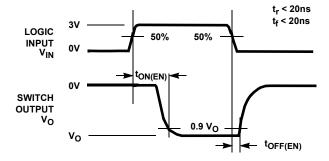
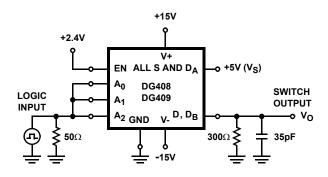


FIGURE 2C. MEASUREMENT POINTS FIGURE 2. ENABLE SWITCHING TIMES



Test Circuits and Waveforms (Continued)



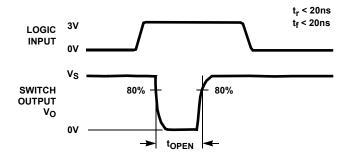
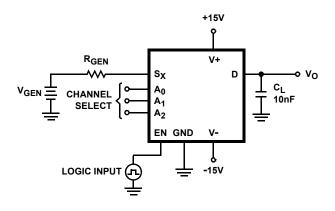


FIGURE 3A. TEST CIRCUIT

FIGURE 3B. MEASUREMENT POINTS

FIGURE 3. BREAK-BEFORE-MAKE INTERVAL



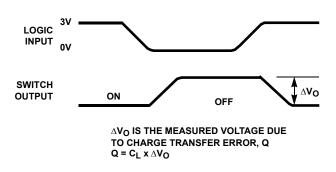


FIGURE 4A. TEST CIRCUIT

FIGURE 4B. MEASUREMENT POINTS

FIGURE 4. CHARGE INJECTION

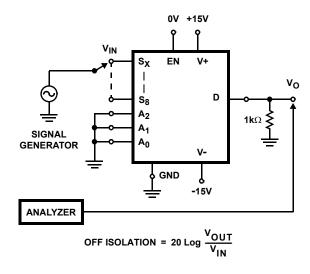


FIGURE 5. OFF ISOLATION

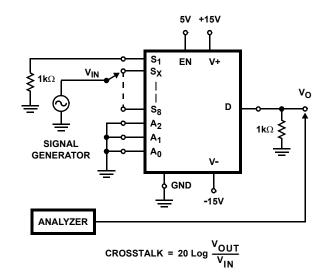


FIGURE 6. CROSSTALK

Test Circuits and Waveforms (Continued)

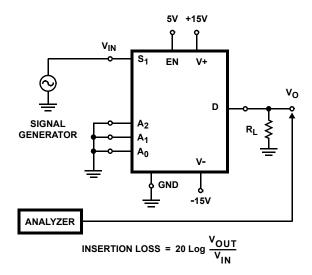


FIGURE 7. INSERTION LOSS

Typical Applications

Overvoltage Protection

A very convenient form of overvoltage protection consists of adding two small signal diodes (1N4148, 1N914 type) in series with the supply pins (see Figure 9). This arrangement effectively blocks the flow of reverse currents. It also floats the supply pin above or below the normal V+ or V- value. In this case the overvoltage signal actually becomes the power supply of the IC. From the point of view of the chip, nothing has changed, as long as the difference V+ - (V-) doesn't exceed 44V. The addition of these diodes will reduce the analog signal range to 1V below V+ and 1V above V-, but it preserves the low channel resistance and low leakage characteristics.

Typical application information is for Design Aid Only, not guaranteed and not subject to production testing.

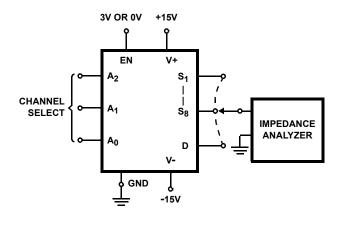


FIGURE 8. SOURCE/DRAIN CAPACITANCES

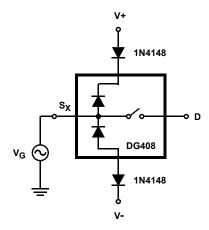


FIGURE 9. OVERVOLTAGE PROTECTION USING BLOCKING DIODES



Typical Performance Curves

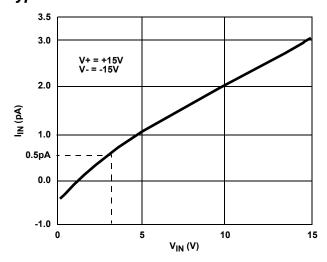


FIGURE 10. INPUT LOGIC CURRENT vs LOGIC INPUT VOLTAGE

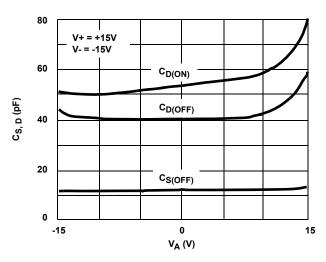


FIGURE 12. SOURCE/DRAIN CAPACITANCE vs ANALOG VOLTAGE

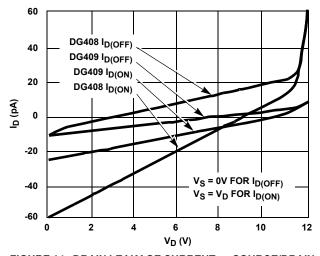


FIGURE 14. DRAIN LEAKAGE CURRENT vs SOURCE/DRAIN VOLTAGE (SINGLE 12V SUPPLY)

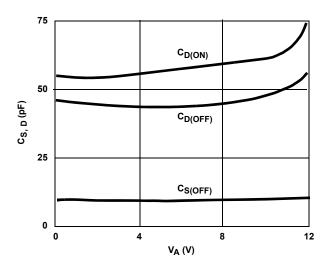


FIGURE 11. SOURCE/DRAIN CAPACITANCE vs ANALOG VOLTAGE (SINGLE 12V SUPPLY)

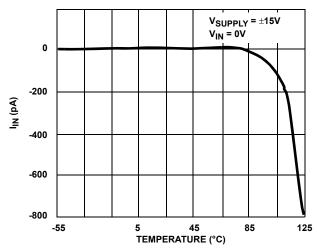


FIGURE 13. LOGIC INPUT CURRENT vs TEMPERATURE

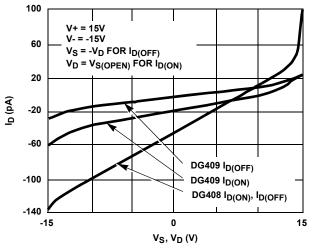


FIGURE 15. DRAIN LEAKAGE CURRENT vs SOURCE/DRAIN VOLTAGE



Typical Performance Curves (Continued)

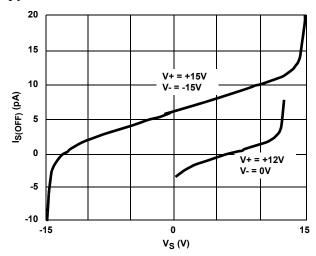


FIGURE 16. SOURCE LEAKAGE CURRENT vs SOURCE VOLTAGE

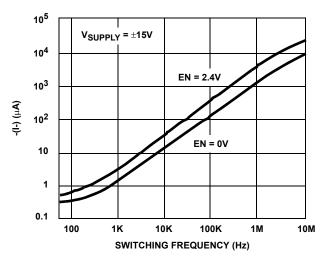


FIGURE 18. NEGATIVE SUPPLY CURRENT vs SWITCHING FREQUENCY

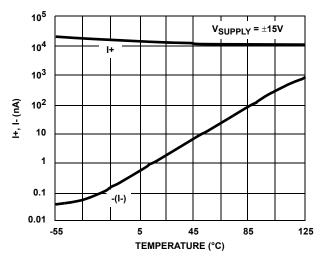


FIGURE 20. I_{SUPPLY} vs TEMPERATURE

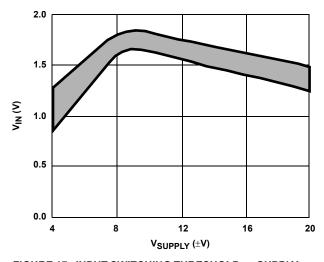


FIGURE 17. INPUT SWITCHING THRESHOLD vs SUPPLY VOLTAGE

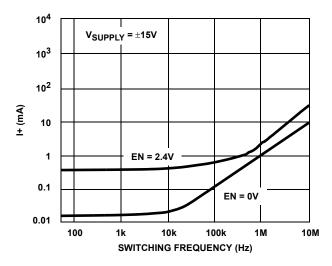


FIGURE 19. POSITIVE SUPPLY CURRENT vs SWITCHING FREQUENCY

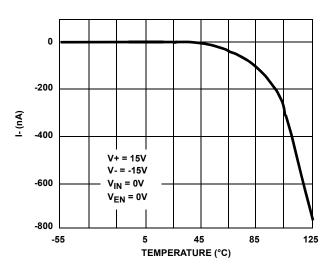


FIGURE 21. NEGATIVE SUPPLY CURRENT vs TEMPERATURE



Typical Performance Curves (Continued)

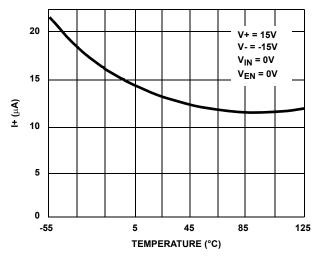


FIGURE 22. POSITIVE SUPPLY CURRENT vs TEMPERATURE (DG408)

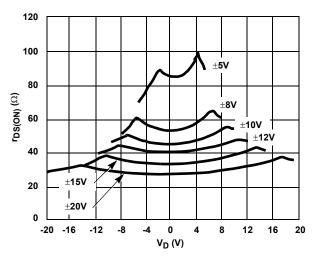


FIGURE 24. $r_{DS(ON)}$ vs V_D AND SUPPLY

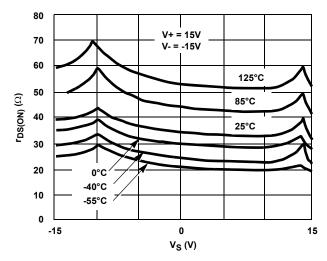


FIGURE 26. r_{DS(ON)} vs V_S AND TEMPERATURE

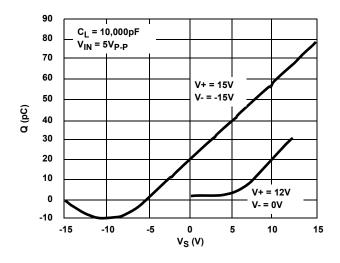


FIGURE 23. CHARGE INJECTION vs ANALOG VOLTAGE

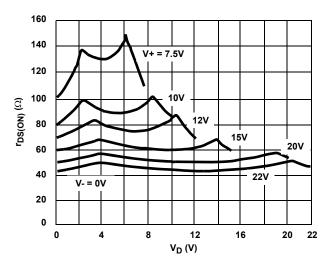


FIGURE 25. r_{DS(ON)} vs V_D (SINGLE SUPPLY)

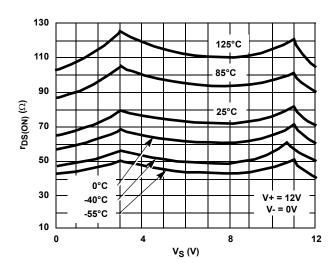


FIGURE 27. $r_{DS(ON)}$ vs v_S and temperature (SINGLE SUPPLY)



Typical Performance Curves (Continued)

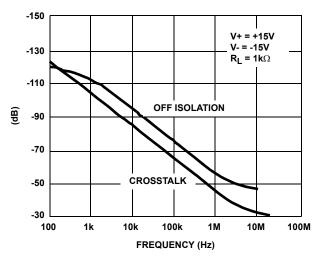


FIGURE 28. OFF ISOLATION AND CROSSTALK vs FREQUENCY

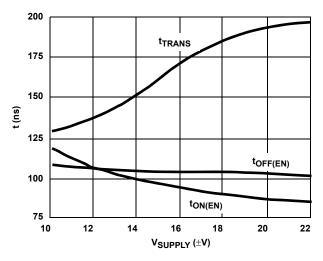


FIGURE 30. SWITCHING TIME vs BIPOLAR SUPPLY

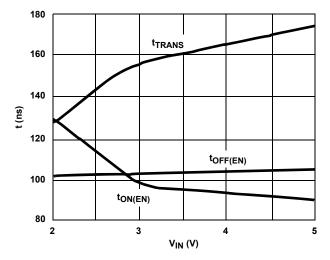


FIGURE 32. SWITCHING TIME vs $V_{\mbox{\footnotesize{IN}}}$ (BIPOLAR SUPPLY)

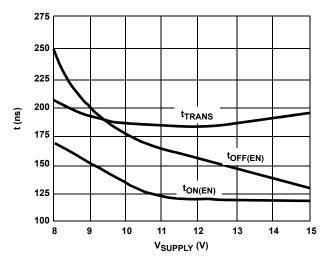


FIGURE 29. SWITCHING TIME vs SINGLE SUPPLY

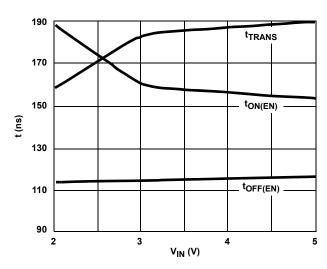


FIGURE 31. SWITCHING TIME vs $V_{\mbox{\scriptsize IN}}$ (SINGLE SUPPLY)

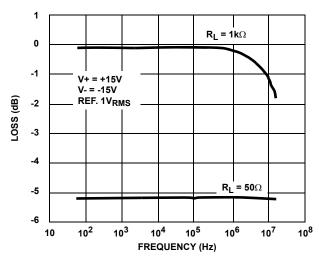


FIGURE 33. INSERTION LOSS vs FREQUENCY



Die Characteristics

DIE DIMENSIONS:

 $1800 \mu m \ x \ 3320 \mu m \ x \ 485 \mu m$

METALLIZATION:

Type: SiAI

Thickness: 12kÅ ±1kÅ

PASSIVATION:

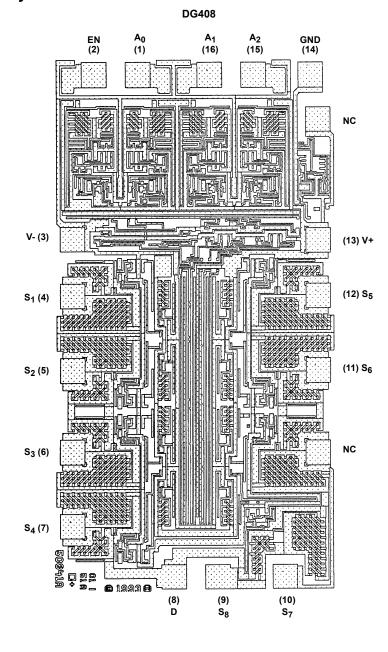
Type: Nitride

Thickness: 8kÅ ±1kÅ

WORST CASE CURRENT DENSITY:

 $9.1 \times 10^4 \text{ A/cm}^2$

Metallization Mask Layout





Die Characteristics

DIE DIMENSIONS:

 $1800 \mu m \ x \ 3320 \mu m \ x \ 485 \mu m$

METALLIZATION:

Type: SiAl

Thickness: 12kÅ ±1kÅ

PASSIVATION:

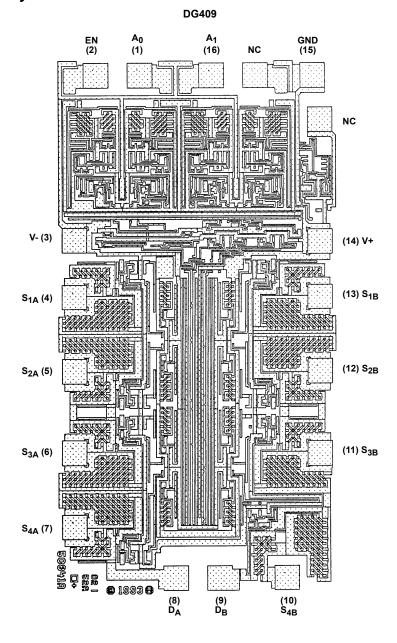
Type: Nitride

Thickness: $8k\text{\AA} \pm 1k\text{\AA}$

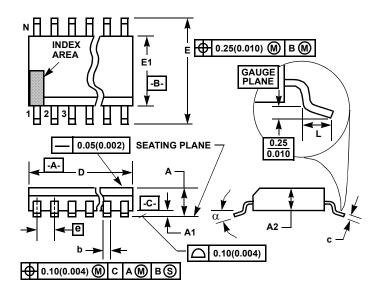
WORST CASE CURRENT DENSITY:

 $9.1 \times 10^4 \text{ A/cm}^2$

Metallization Mask Layout



Thin Shrink Small Outline Plastic Packages (TSSOP)



NOTES:

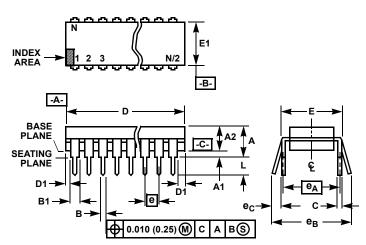
- These package dimensions are within allowable dimensions of JEDEC MO-153-AB, Issue E.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- Dimension "E1" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.15mm (0.006 inch) per side.
- 5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 6. "L" is the length of terminal for soldering to a substrate.
- 7. "N" is the number of terminal positions.
- 8. Terminal numbers are shown for reference only.
- Dimension "b" does not include dambar protrusion. Allowable dambar protrusion shall be 0.08mm (0.003 inch) total in excess of "b" dimension at maximum material condition. Minimum space between protrusion and adjacent lead is 0.07mm (0.0027 inch).
- 10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact. (Angles in degrees)

M16.173
16 LEAD THIN SHRINK SMALL OUTLINE PLASTIC PACKAGE

	INC	HES	MILLIM	IETERS	
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	-	0.043	-	1.10	-
A1	0.002	0.006	0.05	0.15	-
A2	0.033	0.037	0.85	0.95	-
b	0.0075	0.012	0.19	0.30	9
С	0.0035	0.008	0.09	0.20	-
D	0.193	0.201	4.90	5.10	3
E1	0.169	0.177	4.30	4.50	4
е	0.026	BSC	0.65	BSC	-
Е	0.246	0.256	6.25	6.50	-
L	0.020	0.028	0.50	0.70	6
N	16		1	6	7
α	0°	8 ⁰	0°	8 ⁰	-

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Dual-In-Line Plastic Packages (PDIP)



NOTES:

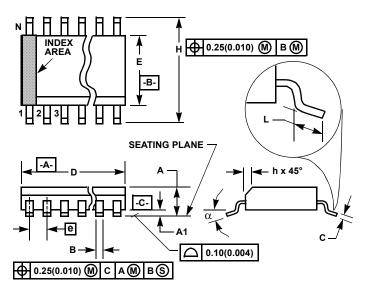
- 1. Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- 3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
- 4. Dimensions A, A1 and L are measured with the package seated in JE-DEC seating plane gauge GS-3.
- 5. D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
- 6. E and $|e_A|$ are measured with the leads constrained to be perpendicular to datum -C-
- 7. e_B and e_C are measured at the lead tips with the leads unconstrained. eC must be zero or greater.
- 8. B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
- 9. N is the maximum number of terminal positions.
- 10. Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

E16.3 (JEDEC MS-001-BB ISSUE D) 16 LEAD DUAL-IN-LINE PLASTIC PACKAGE

	INC	INCHES MILLIMETERS			
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	-	0.210	-	5.33	4
A1	0.015	-	0.39	-	4
A2	0.115	0.195	2.93	4.95	-
В	0.014	0.022	0.356	0.558	-
B1	0.045	0.070	1.15	1.77	8, 10
С	0.008	0.014	0.204	0.355	-
D	0.735	0.775	18.66	19.68	5
D1	0.005	-	0.13	-	5
Е	0.300	0.325	7.62	8.25	6
E1	0.240	0.280	6.10	7.11	5
е	0.100	BSC	2.54 BSC		-
e _A	0.300	BSC	7.62	BSC	6
e _B	-	0.430	-	10.92	7
L	0.115	0.150	2.93	3.81	4
N	1	6	1	6	9

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Small Outline Plastic Packages (SOIC)



NOTES:

- Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Dimension "D" does not include mold flash, protrusions or gate burrs.
 Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- 4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
- 5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 6. "L" is the length of terminal for soldering to a substrate.
- 7. "N" is the number of terminal positions.
- 8. Terminal numbers are shown for reference only.
- The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
- Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

M16.15 (JEDEC MS-012-AC ISSUE C)
16 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

	INC	HES	MILLIM	ETERS	
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	0.0532	0.0688	1.35	1.75	-
A1	0.0040	0.0098	0.10	0.25	-
В	0.013	0.020	0.33	0.51	9
С	0.0075	0.0098	0.19	0.25	-
D	0.3859	0.3937	9.80	10.00	3
Е	0.1497	0.1574	3.80	4.00	4
е	0.050	BSC	1.27	1.27 BSC	
Н	0.2284	0.2440	5.80	6.20	-
h	0.0099	0.0196	0.25	0.50	5
L	0.016	0.050	0.40	1.27	6
N	1	6	1	6	7
α	0°	8°	0°	8°	-

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